

**500V N-CHANNEL ENHANCEMENT MODE MOSFET**

**MAIN CHARACTERISTICS**

$I_D$	28A
$V_{DSS}$	500V
$R_{DS(on)-typ}(@V_{GS}=10V)$	<0.18Ω (Type:0.14Ω)

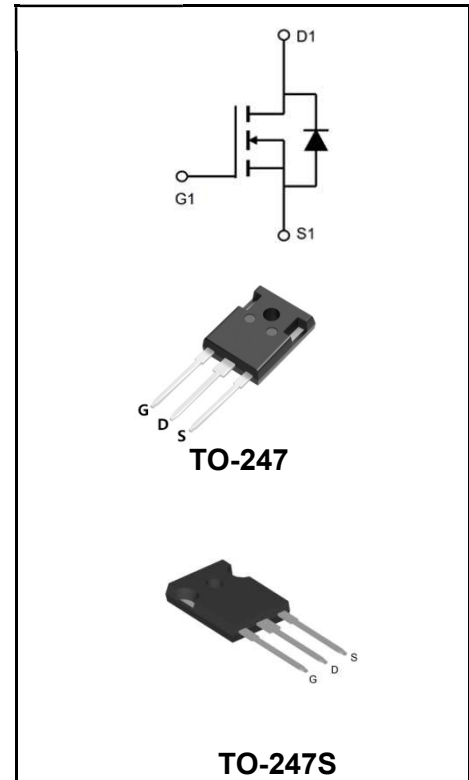
**Features**

- ◆Fast Switching
- ◆Low ON Resistance
- ◆Low Gate Charge
- ◆100% Single Pulse avalanche energy Test
- ◆LeadfreeincomplywithEUroHS2011/65/EUdirectives



**Mechanical Data**

- ◆Case: Molded plastic
- ◆Mounting Position: Any
- ◆Molded Plastic: UL Flammability Classification Rating 94V-0
- ◆Solder bath temperature275°C maximum,10s per JESD22-106



**Product Specification Classification**

Part Number	Package	Marking	Pack
YFW28N50AP	TO-247	YFW 28N50AP XXXXX	30PCS/Tube
YFW28N50APS	TO-247S	YFW 28N50APS XXXXX	30PCS/Tube

**Maximum Ratings at Tc=25°C unless otherwise specified**

Characteristics	Symbols	Value	Units
		247/247S	
Drain-Source Voltage	<b>V<sub>DS</sub></b>	500	<b>V</b>
Gate-Source Voltage	<b>V<sub>GS</sub></b>	±30	<b>V</b>
Continue Drain Current	<b>I<sub>D</sub></b>	28	<b>A</b>
-Continuous (TC = 100°C)		19	
Pulsed Drain Current (Note1)	<b>I<sub>DM</sub></b>	100	<b>A</b>
Power Dissipation	<b>P<sub>D</sub></b>	300	<b>W</b>
-Derate above 25°C		2.5	
Single Pulse Avalanche Energy (Note2)	<b>E<sub>AS</sub></b>	1500	<b>mJ</b>
Avalanche Current (Note 1)	<b>I<sub>AR</sub></b>	28	<b>A</b>
Repetitive Avalanche Energy (Note 1)	<b>E<sub>AS</sub></b>	32	<b>mJ</b>
Operating Temperature Range	<b>T<sub>J</sub></b>	150	<b>°C</b>
Storage Temperature Range	<b>T<sub>STG</sub></b>	-55 to +150	<b>°C</b>
Thermal Resistance, Junction to Case	<b>R<sub>θJC</sub></b>	0.42	<b>°C/W</b>
Thermal Resistance, Junction to Ambient	<b>R<sub>θJA</sub></b>	40	<b>°C/W</b>

**Maximum Ratings at Tc=25°C unless otherwise specified**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	<b>BV<sub>DSS</sub></b>	500	-	-	<b>V</b>
Breakdown Voltage Temperature Coefficient	I <sub>D</sub> =250μA (Referenced to 25°C)	$\frac{\Delta BVDSS}{\Delta T_J}$	-	0.5	-	<b>V/°C</b>
Drain-Source Leakage Current	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V	<b>I<sub>DSS</sub></b>	-	-	1	<b>uA</b>
	V <sub>DS</sub> = 400 V, T <sub>c</sub> = 125°C		-	-	10	
Gate Leakage Current	V <sub>GS</sub> = ± 30 V, V <sub>DS</sub> = 0 V	<b>I<sub>GSS</sub></b>	-	-	±100	<b>nA</b>
Gate-Source Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	<b>V<sub>GS(th)</sub></b>	2	0	4	<b>V</b>
Drain-Source On-State Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14A	<b>R<sub>DS(on)</sub></b>	-	0.14	0.18	<b>Ω</b>
Forward Transconductance	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 14 A	<b>g<sub>fs</sub></b>	-	18	-	<b>S</b>
Input Capacitance	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1MHz	<b>C<sub>iss</sub></b>	-	4611	-	<b>pF</b>
Output Capacitance		<b>C<sub>oss</sub></b>	-	225	-	
Reverse Transfer Capacitance		<b>C<sub>rss</sub></b>	-	12	-	
Turn-on Delay Time	I <sub>D</sub> = 28, V <sub>DD</sub> = 250V, R <sub>G</sub> =25Ω(Note3,4)	<b>td(ON)</b>	-	37.2	-	<b>nS</b>
Rise Time		<b>tr</b>	-	64.4	-	
Turn-Off Delay Time		<b>td(OFF)</b>	-	86.8	-	
Fall Time		<b>tf</b>	-	46	-	
Total Gate Charge	I <sub>D</sub> =28 A, V <sub>DD</sub> = 400 V, V <sub>GS</sub> = 10 V(Note3,4)	<b>Q<sub>G</sub></b>	-	121	-	<b>nC</b>
Gate to Source Charge		<b>Q<sub>GS</sub></b>	-	20	-	
Gate to Drain Charge		<b>Q<sub>GD</sub></b>	-	32	-	

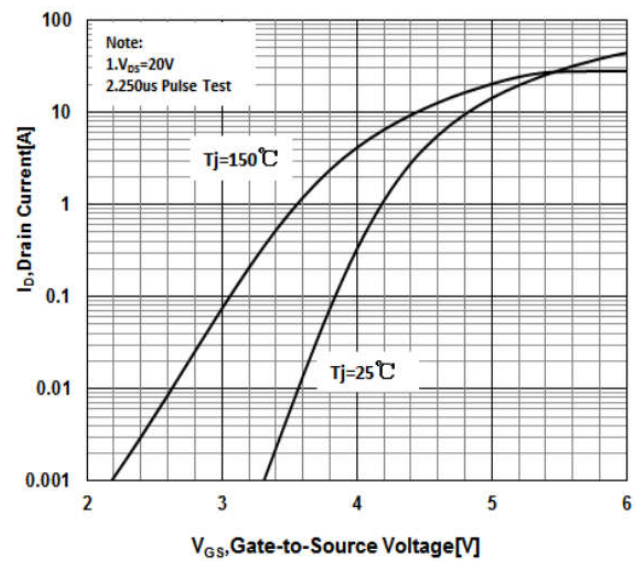
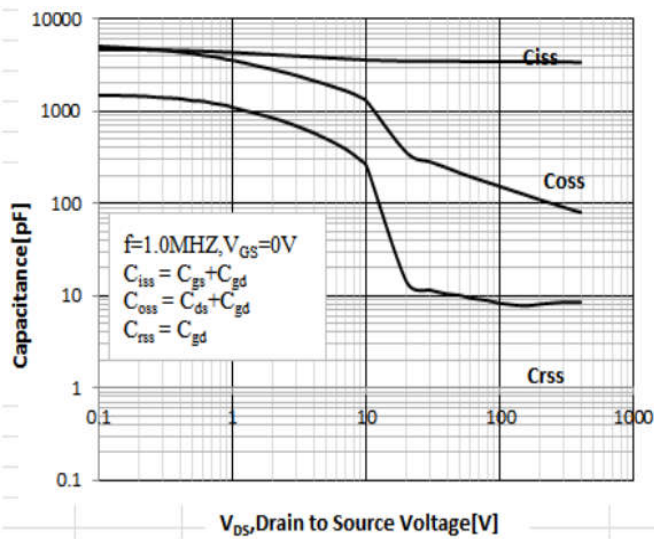
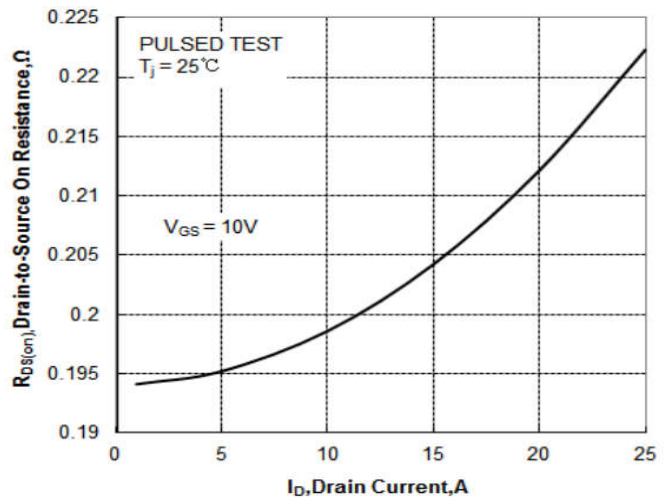
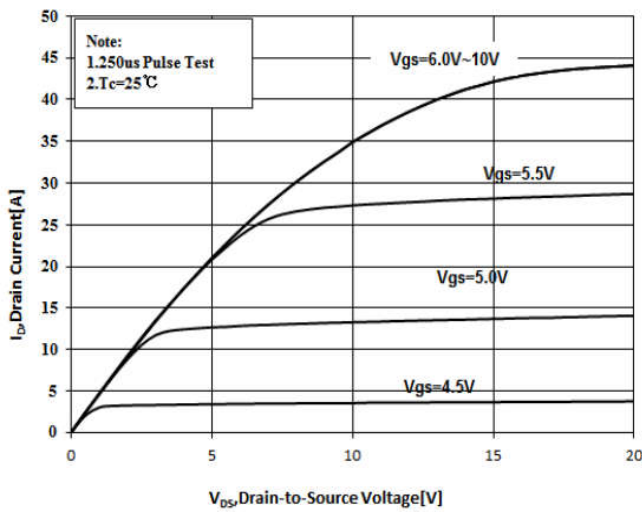
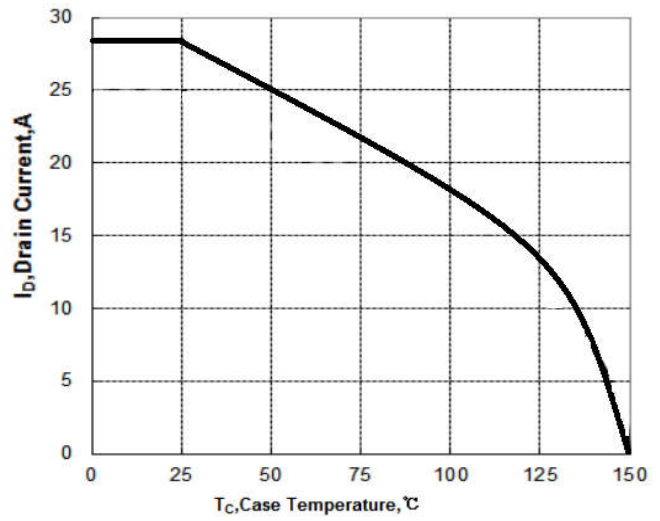
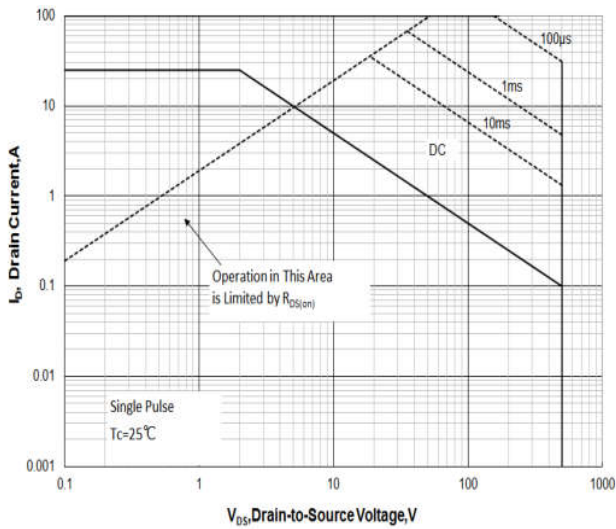
**Source-Drain Diode Characteristics at Ta=25°C unless otherwise specified**

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Maximun Body-Diode Continuous Current		<b>I<sub>S</sub></b>	-	-	25	<b>A</b>
Maximun Body-Diode Pulsed Current		<b>I<sub>SM</sub></b>	-	-	100	<b>A</b>
Drain-Source Diode Forward Voltage	$I_{SD} = 28A$	<b>V<sub>SD</sub></b>	-	-	1.5	<b>V</b>
Reverse Recovery Time	$I_{SD} = 28A, V_{GS} = 0 V,$ $dI_f / dt = 100 A/\mu s$	<b>trr</b>	-	490	-	<b>nS</b>
Reverse Recovery Charge		<b>Qrr</b>	-	6.2	-	<b>uC</b>

Note:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. IAS = 28 A, VDD = 50 V, L = 4mH, RG = 25Ω, starting TJ = 25°C.
3. ulse test: Pulse Width ≤300 μ s, Duty Cycle≤2%.
4. Essentially Independent of Operating Temperature.

Ratings and Characteristic Curves



Package Outline Dimensions Millimeters

TO-247

	Dim.	Min.	Max.
	A	15	16
	B	20	21
	C	41	42
	D	5	6
	E	4	5
	F	2.5	3.5
	G	1.75	2.5
	H	3	3.5
	I	8	10
	J	4.9	5.1
	K	1.9	2.1
L	3.5	4	
M	4.75	5.25	
N	2	3	
O	0.55	0.75	
P	Typ 5.08		
Q	1.2	1.3	
All Dimensions in millimeter			

TO-247S

	Dim.	Min.	Max.
	A	15	16
	B	19.5	20.5
	C	33.5	35.5
	D	5	6
	E	3.5	4.5
	F	2.5	3.5
	G	1.75	2.5
	H	3	4
	I	9	11
	J	4.9	5.1
	K	1	1.3
L	3.75	4.25	
M	4.75	5.25	
N	1.8	2.2	
O	0.45	0.6	
P	Typ 5.08		
Q	1.2	1.3	
All Dimensions in millimeter			